


<b>Search Notes</b>  	<b>Application/Control No.</b>  10500401	<b>Applicant(s)/Patent Under Reexamination</b>  OIWA ET AL.
	<b>Examiner</b>  SYED Y HASAN	<b>Art Unit</b>  2621

SEARCHED			
Class	Subclass	Date	Examiner
386	92	3/19/2008	Syed Y. Hasan
386	68	3/19/2008	Syed Y. Hasan
386	83	3/19/2008	Syed Y. Hasan
386	125	3/19/2008	Syed Y. Hasan
386	E5.002	3/19/2008	Syed Y. Hasan
386	E9.013	3/19/2008	Syed Y. Hasan
369	30.2	3/19/2008	Syed Y. Hasan
369	47.16	3/19/2008	Syed Y. Hasan
369	47.24	3/19/2008	Syed Y. Hasan
369	47.29	3/19/2008	Syed Y. Hasan
369	124.04	3/19/2008	Syed Y. Hasan
369	124.14	3/19/2008	Syed Y. Hasan
369	275.3	3/19/2008	Syed Y. Hasan
370	498	3/19/2008	Syed Y. Hasan
707	200	3/19/2008	Syed Y. Hasan
711	112	3/19/2008	Syed Y. Hasan
725	146	3/19/2008	Syed Y. Hasan
348	E5.105, E7.061	2/26/2009	Syed Y. Hasan
386	109, 112	2/26/2009	Syed Y. Hasan
711	153, 173	2/26/2009	Syed Y. Hasan
725	38, 40, 44, 55, 59, 61, 89, 133, 134, 141, 153	2/26/2009	Syed Y. Hasan
386	126	9/2/2009	Syed Y. Hasan
375	E7.093, E7.18, 7.181	9/2/2009	Syed Y. Hasan
G9B	27.012, 27.019, 27.033, 27.047, 27.05, 27.051	9/2/2009	Syed Y. Hasan
714	763	6/17/2010	Syed Y. Hasan
G9B	20.009, 20.014, 20.015, 20.046, 20.059	6/17/2010	Syed Y. Hasan

SEARCH NOTES		
Search Notes	Date	Examiner
USPAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB	3/19/2008	Syed Y. Hasan
Consultation with James Fletcher	3/18/2008	Syed Y. Hasan

INTERFERENCE SEARCH
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Class	Subclass	Date	Examiner

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